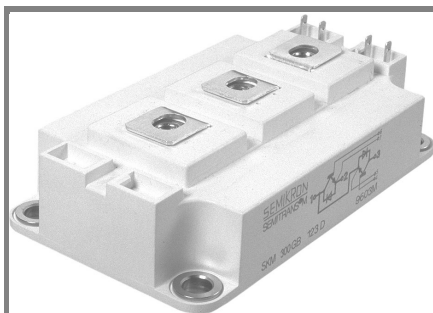


# SKM 400GB126D



**SEMITRANS™ 3**

## Trench IGBT Module

**SKM 400GB126D**

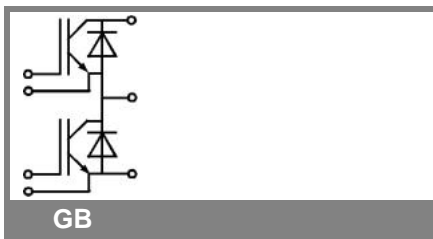
Preliminary Data

### Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CEsat}$  with positive temperature coefficient
- High short circuit capability, self limiting to  $6 \times I_C$

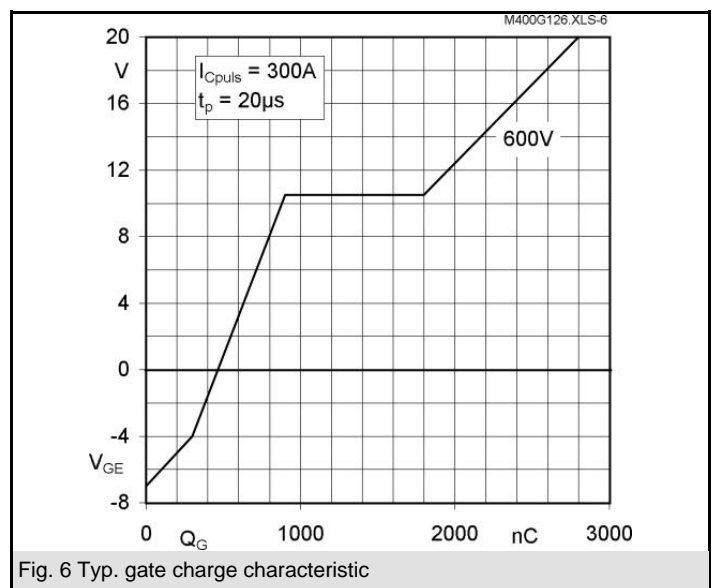
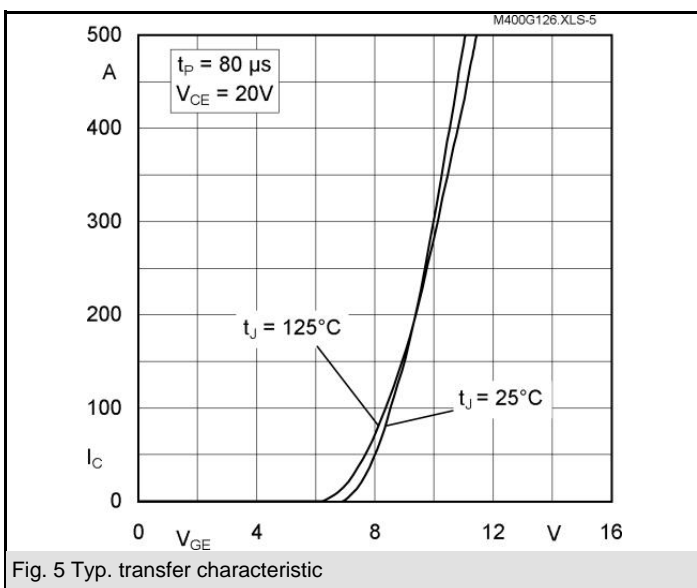
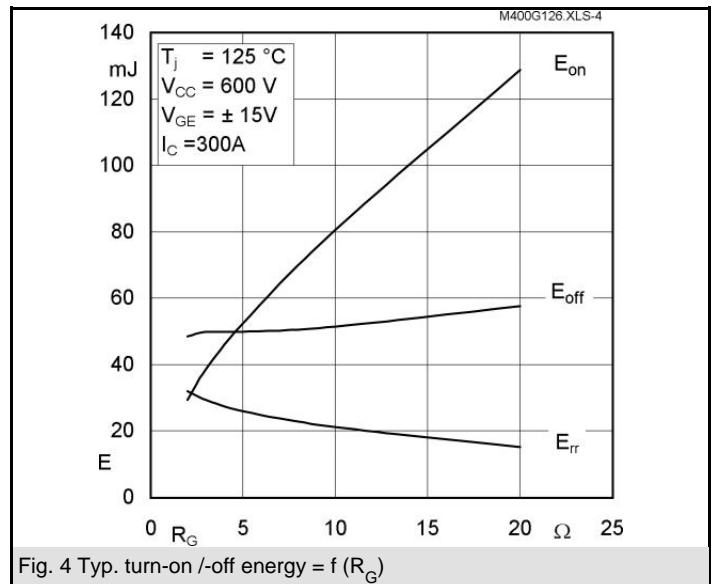
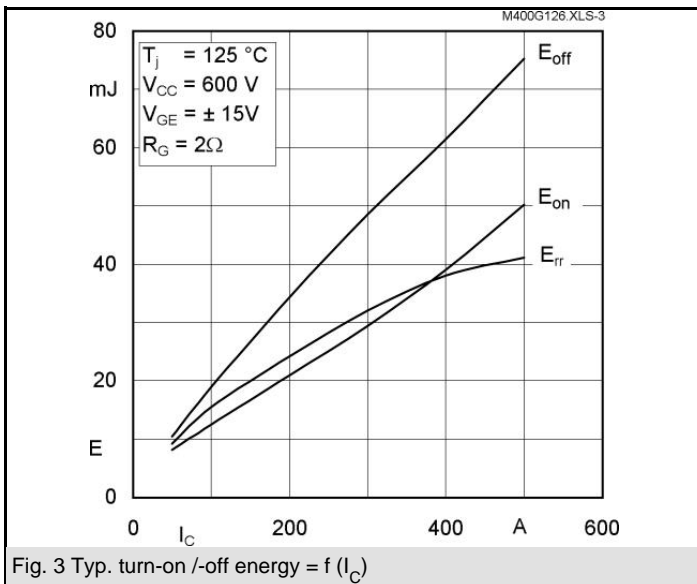
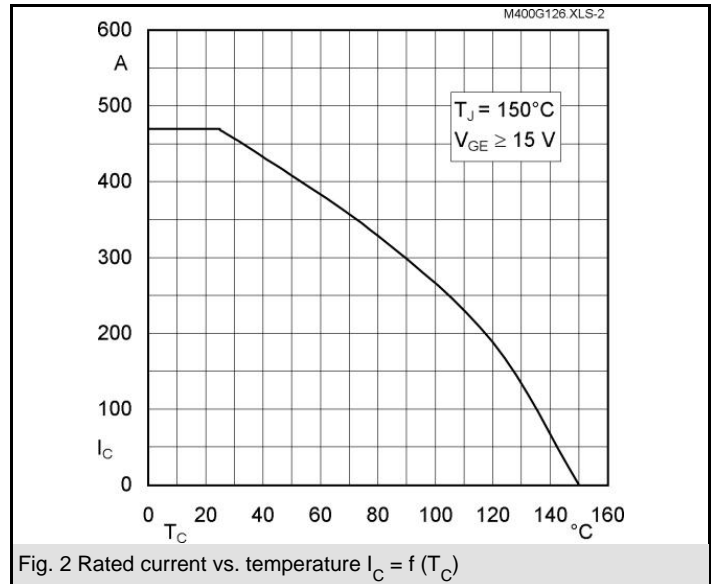
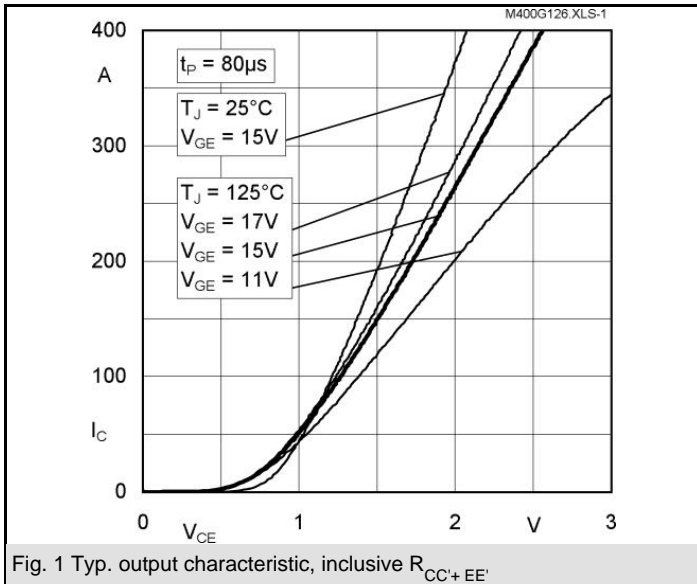
### Typical Applications

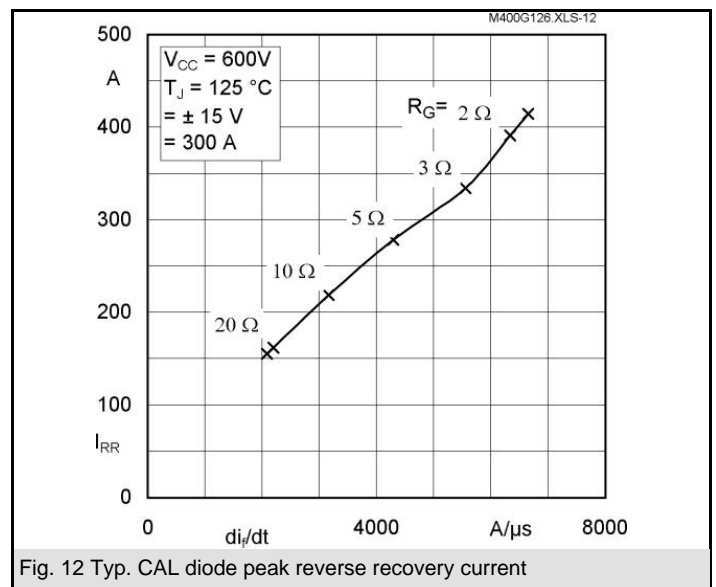
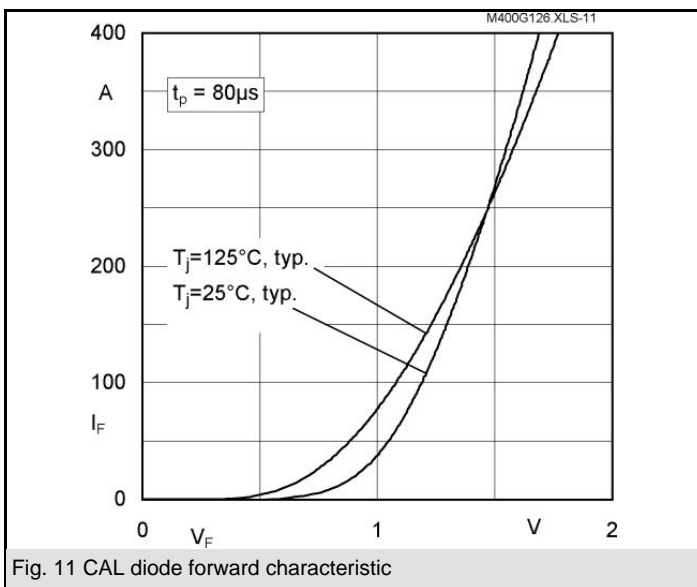
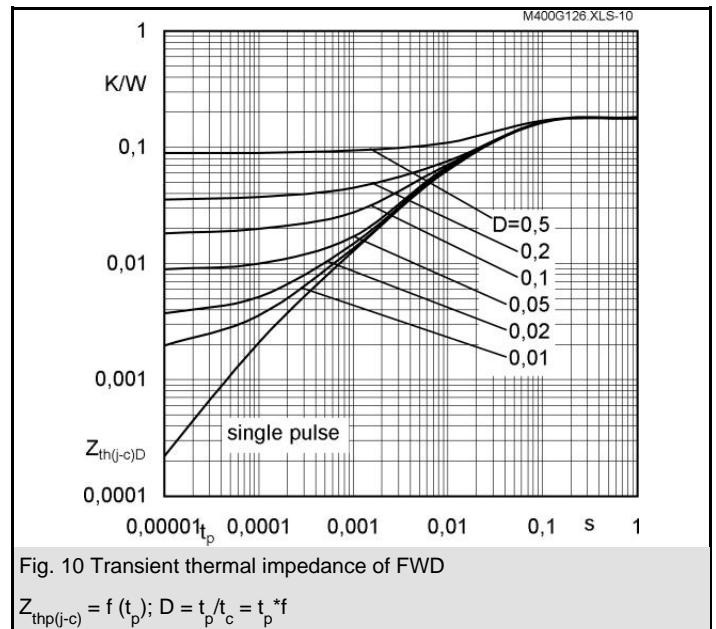
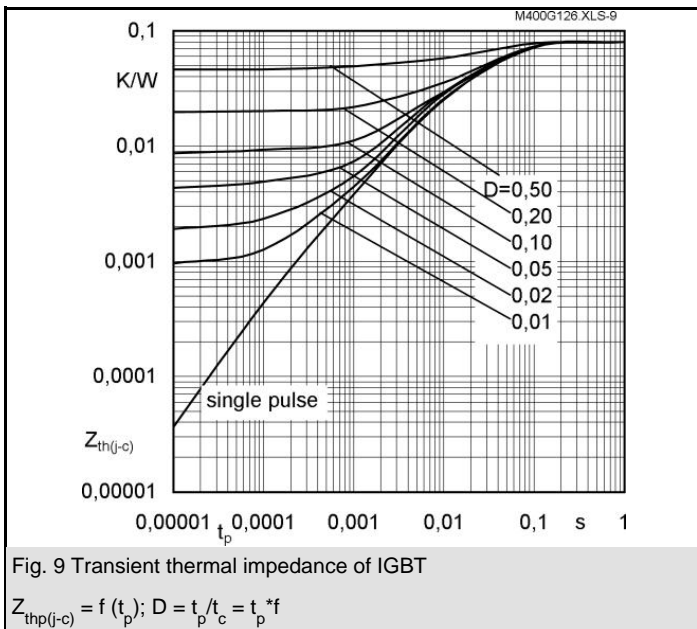
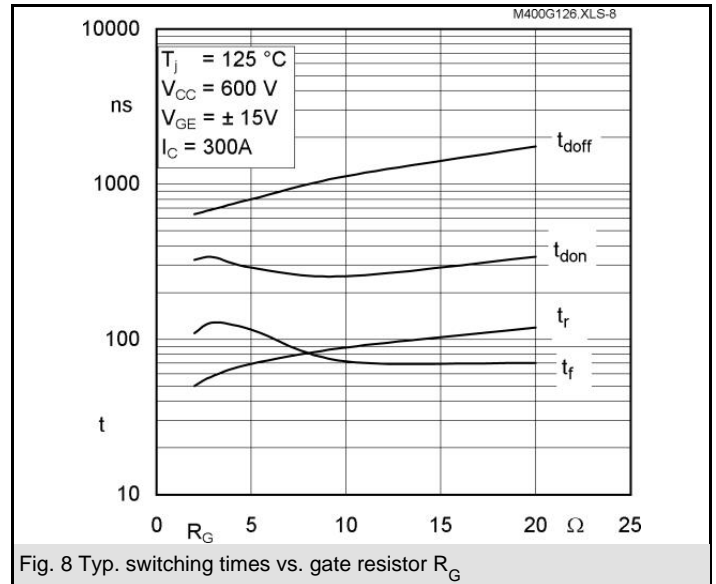
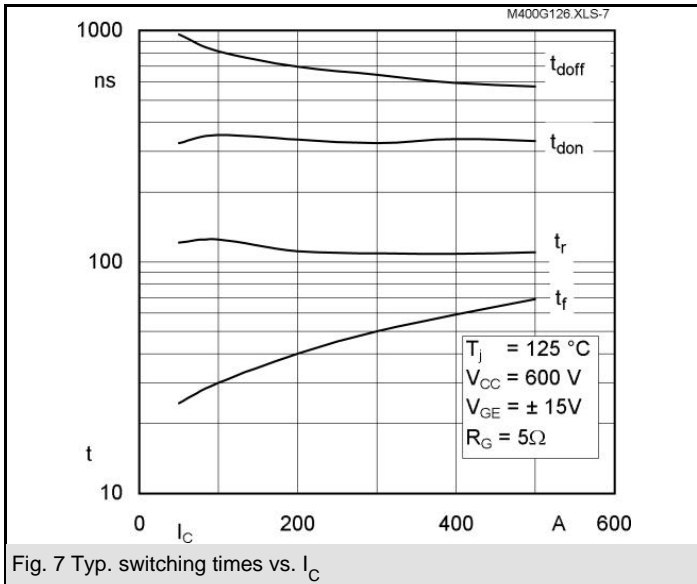
- AC inverter drives
- UPS
- Electronic welders



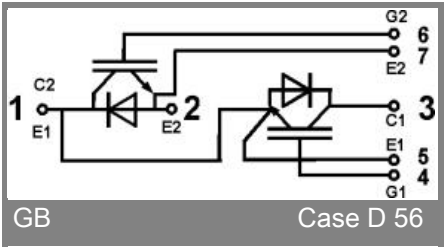
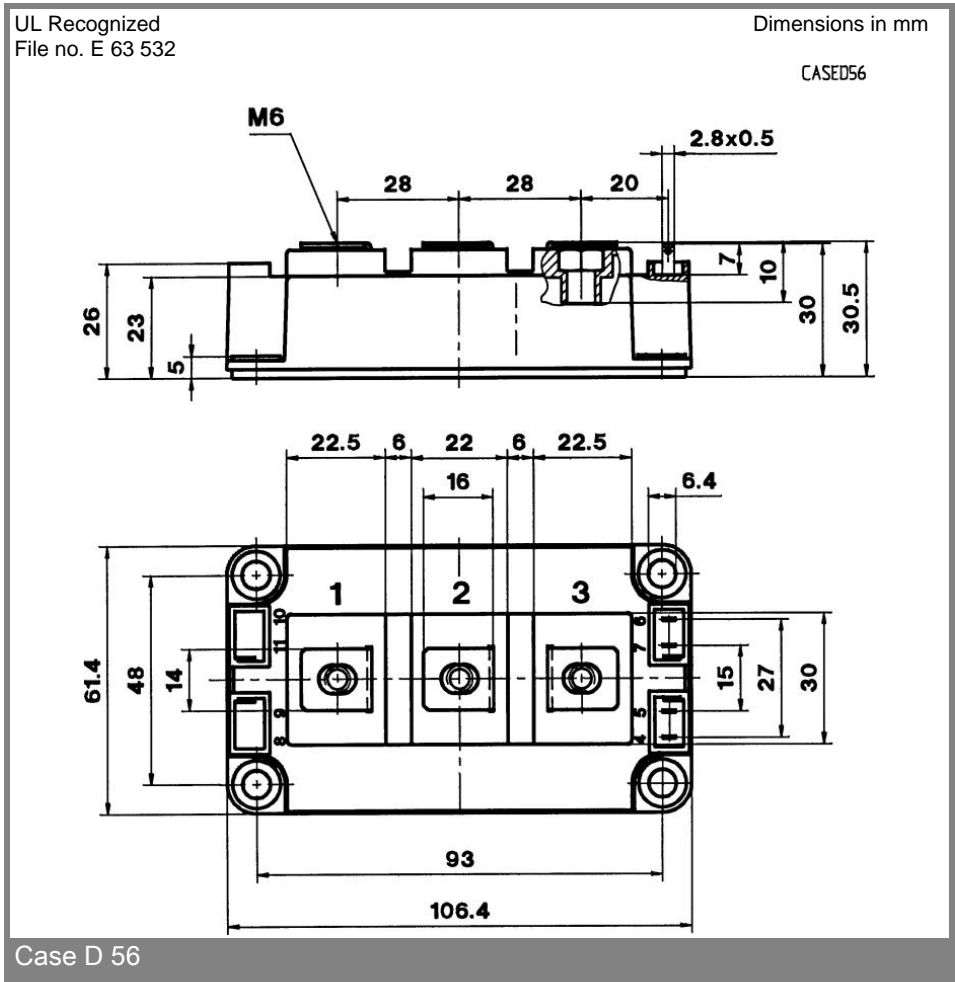
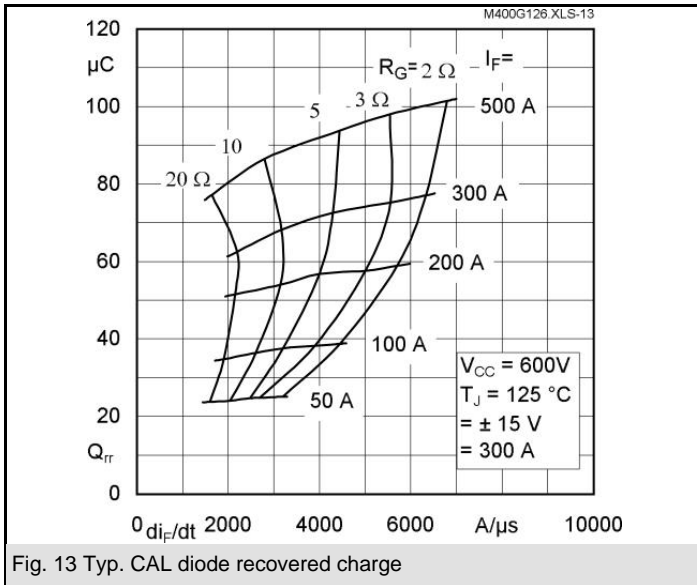
Absolute Maximum Ratings		$T_c = 25\text{ °C}$ , unless otherwise specified	
Symbol	Conditions	Values	Units
<b>IGBT</b>			
$V_{CES}$		1200	V
$I_C$	$T_c = 25\text{ (80) °C}$	470 (330)	A
$I_{CRM}$	$t_p = 1\text{ ms}$	600	A
$V_{GES}$		$\pm 20$	V
$T_{vj}$ ( $T_{stg}$ )	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	°C
$V_{isol}$	AC, 1 min.	4000	V
<b>Inverse diode</b>			
$I_F$	$T_c = 25\text{ (80) °C}$	400 (270)	A
$I_{FRM}$	$t_p = 1\text{ ms}$	600	A
$I_{FSM}$	$t_p = 10\text{ ms}$ ; sin.; $T_j = 150\text{ °C}$		A

Characteristics		$T_c = 25\text{ °C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}$ ; $I_C = 12\text{ mA}$	5	5,8	6,5	V
$I_{CES}$	$V_{GE} = 0$ ; $V_{CE} = V_{CES}$ ; $T_j = 25\text{ (125) °C}$		0,15	0,45	mA
$V_{CE(TO)}$	$T_j = 25\text{ (125) °C}$		1 (0,9)	1,2	V
$r_{CE}$	$V_{GE} = 15\text{ V}$ ; $T_j = 25\text{ (125) °C}$		2,3 (3,7)	3,2	mΩ
$V_{CE(sat)}$	$I_{Cnom} = 300\text{ A}$ ; $V_{GE} = 15\text{ V}$ ; chip level		1,7 (2)	2,15	V
$C_{ies}$	under following conditions		23,1		nF
$C_{oes}$	$V_{GE} = 0$ ; $V_{CE} = 25\text{ V}$ ; $f = 1\text{ MHz}$		1,9		nF
$C_{res}$			1,2		nF
$L_{CE}$				20	nH
$R_{CC'+EE'}$	res.; terminal-chip $T_c = 25\text{ (125) °C}$		0,35 (0,5)		mΩ
$t_{d(on)}$	$V_{CC} = 600\text{ V}$ ; $I_{Cnom} = 300\text{ A}$		330		ns
$t_r$	$R_{Gon} = R_{Goff} = 2\text{ Ω}$ ; $T_j = 125\text{ °C}$		50		ns
$t_{d(off)}$	$V_{GE} = \pm 15\text{ V}$		650		ns
$t_f$			110		ns
$E_{on} (E_{off})$			29 (48)		mJ
<b>Inverse diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 300\text{ A}$ ; $V_{GE} = 0\text{ V}$ ; $T_j = 25\text{ (125) °C}$		1,6 (1,6)	1,8 (1,8)	V
$V_{(TO)}$	$T_j = 25\text{ (125) °C}$		1 (0,8)	1,1	V
$r_T$	$T_j = 25\text{ (125) °C}$		2 (2,7)	2,3	mΩ
$I_{RRM}$	$I_{Fnom} = 300\text{ A}$ ; $T_j = 125\text{ ( ) °C}$		390		A
$Q_{rr}$	$di/dt = 6300\text{ A/μs}$		77		μC
$E_{rr}$	$V_{GE} = 0\text{ V}$		32		mJ
<b>Thermal characteristics</b>					
$R_{th(j-c)}$	per IGBT			0,08	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,18	K/W
$R_{th(c-s)}$	per module			0,038	K/W
<b>Mechanical data</b>					
$M_s$	to heatsink M6	3		5	Nm
$M_t$	to terminals M6	2,5		5	Nm
w				325	g





# SKM 400GB126D



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.